

AON6484

100V N-Channel MOSFET

General Description

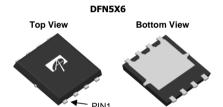
The AON6484 combines advanced trench MOSFET technology with a low resistance package to provide extremely low R_{DS(ON)}. This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

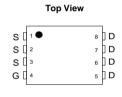
Product Summary

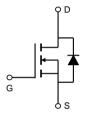
 $\begin{array}{ll} V_{DS} & 100V \\ I_{D} \; (at \, V_{GS} \! = \! 10V) & 12A \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 10V) & < 79 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 4.5V) & < 90 m\Omega \end{array}$

100% UIS Tested 100% R_g Tested









Absolute Maximum Ratings	T _A =25°C unless otherwise noted
D	0

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	100	V	
Gate-Source Voltage		V_{GS}	±20	V	
Continuous Drain	T _C =25°C		12.0		
Current ^G	T _C =100°C	l _D	7.5	A	
Pulsed Drain Current ^c		I _{DM}	27		
Continuous Drain	T _A =25°C	1	3.3	Δ.	
Current	T _A =70°C	IDSM	2.7	Α Α	
Avalanche Current ^C		I _{AS} , I _{AR}	14	A	
Avalanche energy L=0.1mH ^C		E _{AS} , E _{AR}	10	mJ	
	T _C =25°C	Р	25.0	W	
Power Dissipation ^B	T _C =100°C	— P _D —	10.0	VV	
	T _A =25°C	Ь	2	10/	
Power Dissipation A	T _A =70°C	— P _{DSM}	1.3	W	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C	

Thermal Characteristics					
Parameter		Symbol	Тур	Max	Units
Maximum Junction-to-Ambient A	t ≤ 10s	D	21	25	°C/W
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	50	60	°C/W
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	3.5	5	°C/W



Electrical Characteristics (T_{.1}=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
STATIC PARAMETERS							
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu A,\ V_{GS}=0V$	100			V	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =100V, V _{GS} =0V			1	μА	
-	Cata Dadu laskana august	T _J =55°C			5		
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} = ±20V			±100	nA	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=250\mu A$	1.6	2.2	2.7	V	
$I_{D(ON)}$	On state drain current	V _{GS} =10V, V _{DS} =5V	27			Α	
R _{DS(ON)} Static Drain-Source On-Resistance		V _{GS} =10V, I _D =7.5A		63.5	79	mΩ	
	Static Drain-Source On-Resistance	T _J =125°C		122	151		
		V_{GS} =4.5V, I_D =5A		70	90	mΩ	
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =7.5A		34		S	
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.74	1	V	
I_S	Maximum Body-Diode Continuous Current				25	Α	
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance		620	778	942	pF	
Coss	Output Capacitance	V _{GS} =0V, V _{DS} =50V, f=1MHz	38	55	81	pF	
C_{rss}	Reverse Transfer Capacitance		13	24	35	pF	
R_g	Gate resistance	$V_{GS}=0V$, $V_{DS}=0V$, $f=1MHz$	0.7	1.45	2.2	Ω	
SWITCHII	NG PARAMETERS				-		
Q _g (10V)	Total Gate Charge		15	19.4	24	nC	
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =50V, I _D =7.5A	7	9.6	12	nC	
Q_{gs}	Gate Source Charge		2.4	3	3.6	nC	
Q_{gd}	Gate Drain Charge	1 1	3	5	7	nC	
t _{D(on)}	Turn-On DelayTime			6		ns	
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =50V, R_L =6.6 Ω , R_{GEN} =3 Ω		2.5		ns	
t _{D(off)}	Turn-Off DelayTime			21		ns	
t _f	Turn-Off Fall Time	<u>] </u>		2.4		ns	
t _{rr}	Body Diode Reverse Recovery Time	I _F =7.5A, dI/dt=500A/μs	16	23	30	ns	
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =7.5A, dl/dt=500A/μs	99	142	185	nC	

A. The value of $R_{\theta,JA}$ is measured with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^{\circ}$ C. The Power dissipation P_{DSM} is based on R $_{0JA}$ and the maximum allowed junction temperature of 150 $^{\circ}$ C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initial

D. The R_{0JA} is the sum of the thermal impedence from junction to case R_{0JC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

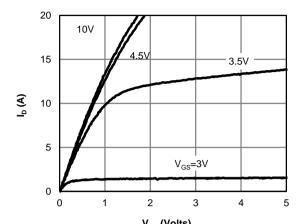
F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

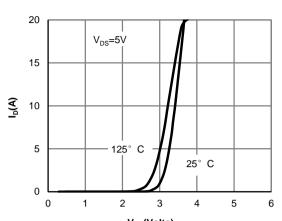
H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.



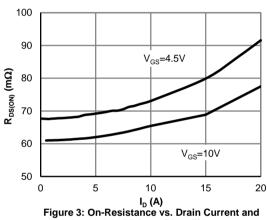
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



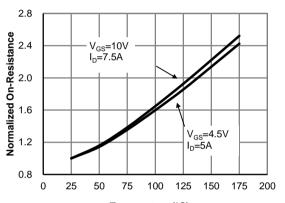
 $V_{\rm DS}$ (Volts) Fig 1: On-Region Characteristics (Note E)



V_{GS}(Volts)
Figure 2: Transfer Characteristics (Note E)



Gate Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature (Note E)

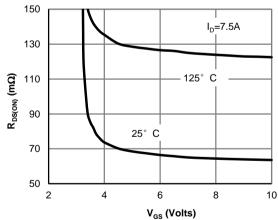
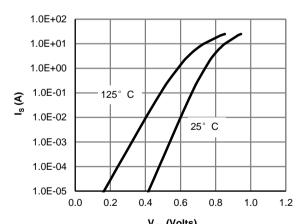


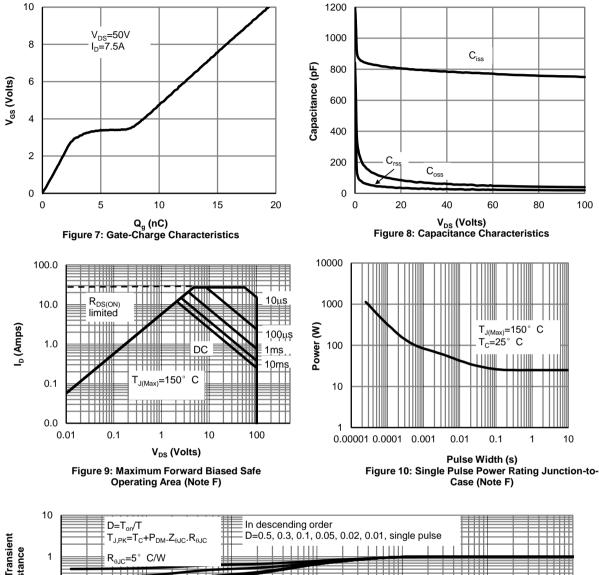
Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



D=T_{on}/T T_{J,PK}=T_C+P_{DM}.Z_{0,JC}.R_{0,JC}
D=0.5, 0.3, 0.1, 0.05, 0.02, 0.01, single pulse

0.01
R_{0,C}=5° C/W
O=0.5, 0.3, 0.1, 0.05, 0.02, 0.01, single pulse

0.01
1E-05
0.0001
0.001
0.001
1 1 10

Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

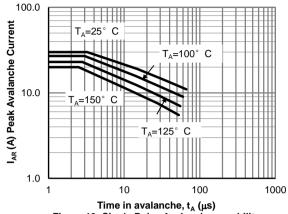
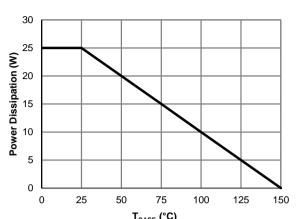
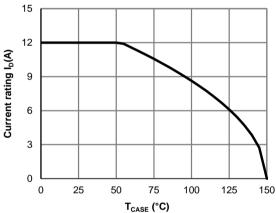


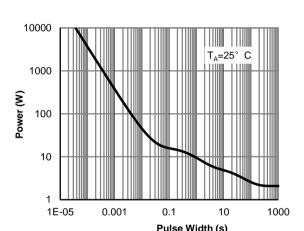
Figure 12: Single Pulse Avalanche capability (Note C)



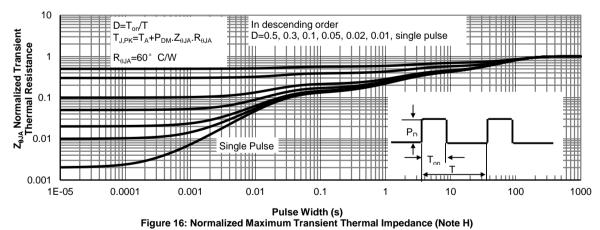
T_{CASE} (°C)
Figure 13: Power De-rating (Note F)



T_{CASE} (°C)
Figure 14: Current De-rating (Note F)

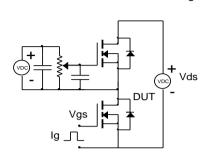


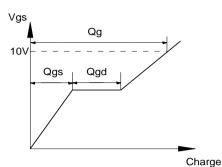
Pulse Width (s)
Figure 15: Single Pulse Power Rating Junction-toAmbient (Note H)



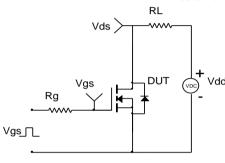


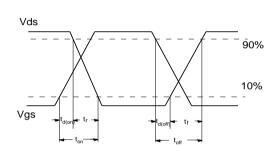
Gate Charge Test Circuit & Waveform



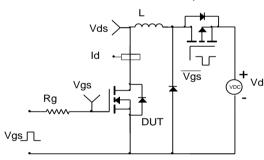


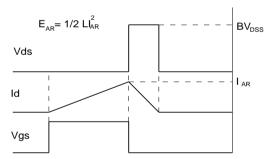
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

